

# 2,2,4,4,6,6-Hexamethyl-8,8-diphenyl-[1,3,5,7,2,4,6,8]

<b>Other names:</b>	2,2,4,4,6,6-hexamethyl-8,8-diphenylcyclotetrasiloxane 1,1,3,3,5,5-Hexamethyl-7,7-diphenylcyclotetrasiloxane
<b>Inchi:</b>	InChI=1S/C18H28O4Si4/c1-23(2)19-24(3,4)21-26(22-25(5,6)20-23,17-13-9-7-10-14-17)1
<b>InchiKey:</b>	BOIFXPDTOHPTOD-UHFFFAOYSA-N
<b>Formula:</b>	C18H28O4Si4
<b>SMILES:</b>	C[Si]1(C)O[Si](C)(C)O[Si](c2ccccc2)(c2ccccc2)O[Si](C)(C)O1
<b>Mol. weight [g/mol]:</b>	420.75
<b>CAS:</b>	1693-44-3

## Physical Properties

Property code	Value	Unit	Source
log10ws	-4.30		Crippen Method
logp	3.428		Crippen Method
rinpol	1883.00		NIST Webbook
ss	758.60	J/molxK	NIST Webbook
ss	758.60	J/molxK	NIST Webbook
tt	304.96 ± 0.02	K	NIST Webbook

## Temperature Dependent Properties

Property code	Value	Unit	Temperature [K]	Source
cps	633.00	J/molxK	298.15	NIST Webbook
hfust	42.73	kJ/mol	304.96	NIST Webbook
hfust	42.73	kJ/mol	305.09	NIST Webbook
hfust	42.73	kJ/mol	305.00	NIST Webbook
sfust	140.10	J/molxK	304.96	NIST Webbook
sfust	140.10	J/molxK	305.09	NIST Webbook

## Sources

Crippen Method:

<http://pubs.acs.org/doi/abs/10.1021/ci9903071>

**Crippen Method:**

[https://www.chemeo.com/doc/models/crippen\\_log10ws](https://www.chemeo.com/doc/models/crippen_log10ws)

**NIST Webbook:**

<http://webbook.nist.gov/cgi/cbook.cgi?ID=C1693443&Units=SI>

## Legend

<b>cps:</b>	Solid phase heat capacity
<b>hfust:</b>	Enthalpy of fusion at a given temperature
<b>log10ws:</b>	Log10 of Water solubility in mol/l
<b>logp:</b>	Octanol/Water partition coefficient
<b>rinpola:</b>	Non-polar retention indices
<b>sfust:</b>	Entropy of fusion at a given temperature
<b>ss:</b>	Solid phase molar entropy at standard conditions
<b>tt:</b>	Triple Point Temperature

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